

Based on Form PTO-1449 (3/90) LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 930058-2004	SERIAL NO. 10/534,592
	APPLICANT David Anthony BARROW	
	FILING DATE May 11, 2005	GROUP Unassigned

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/A.C./	BA	6,582,963 B1	06/24/03	Weigl et al	436	52	
	BB	2002/0090644 A1	07/11/02	Weigl et al	435	7.1	
	BC	2003/0124619 A1	07/03/03	Weigl et al	435	7.1	
	BD	2003/0211507 A1	11/13/03	Hatch et al.	435	6	
	BE	6,368,871 B1	04/09/02	Christel et al.	436	180	
	BF	6,391,541	05/21/02	Petersen et al.	435	5	
	BG	6,431,476 B1	08/13/02	Taylor et al.	241	1	
	BH	6,440,725 B1	08/27/02	Pourahmadi et al.	435	288	
	BI	2002/0055167 A1	05/09/02	Pourahmadi et al.	435	287.2	
	BJ	2004/0166031 A1	08/26/04	Taylor et al.	422	103	
	BK	6,818,185 B1	11/16/04	Petersen et al.	422	102	
	BL	2002/0045246 A1	04/18/02	McMillan et al.	435	306.1	

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
/A.C./	BM	WO 99/09042	02/25/99	WIPO				X
	BN	WO 02/12856 A1	02/14/02	WIPO				X
	BO	WO 01644332	09/07/01	WIPO				X
	BP	WO 02/23163 A1	03/21/02	WIPO				X
	BQ							
	BR							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

BS		
BT		
BU		
EXAMINER /Atif Chaudry/	DATE CONSIDERED 05/09/2008	
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/A.C./	CA	2001/0012612 A1	08/09/01	Petersen et al.	435	5	
	CB	2002/0039783 A1	04/04/02	McMillan et al.	435	287.2	
	CC	2002/0042125 A1	04/11/02	Petersen et al.	435	287.2	
	CD	2002/0019060 A1	02/14/02	Petersen et al.	435	514	
	CE	2002/0175079 A1	11/28/02	Christel et al.	204	601	
	CF	2002/0187547 A1	12/12/02	Taylor et al.	435	306.1	
	CG	2004/0200909 A1	10/14/04	McMillan et al.	241	1	
	CH	2005/0042137 A1	02/24/05	Petersen et al.	422	58	
	CI	2003/0145894 A1	08/07/03	Burns	137	833	
	CJ	2002/0058332 A1	05/16/02	Quake et al.	435	288.3	
	CK	6,524,456 B1	02/25/03	Ramsey et al.	204	450	
	CL	2004/0007463 A1	01/15/04	Ramsey et al.	204	450	
	CM	2002/0155032 A1	10/24/02	Liu et al.	422	100	
	CN	2002/0166592 A1	11/14/02	Liu et al.	137	825	
	CO	2002/0168780 A1	11/14/02	Liu et al.	436	180	
	CP	2003/0175165 A1	09/18/03	Liu	422	100	
	CQ	2002/0142618 A1	10/03/02	Parce et al.	438	751	

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	CQ							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	CR		
	CS		
	CT		
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/A.C./	AA	2002/0182747 A1	12/05/02	Beebe et al.	436	180	
	AB	2001/0055546 A1	12/27/01	Weigl et al.	422	100	
	AC	2003/0201022 A1	10/30/03	Kawai et al.	137	828	
	AD	5,716,852	02/10/98	Yager et al.	436	172	
	AE	5,932,100	08/03/99	Yager et al.	210	634	
	AF	5,948,684	09/07/99	Weigl et al.	436	52	
	AG	5,972,710	10/26/99	Weigl et al.	436	34	
	AH	6,171,865 B1	01/09/01	Weigl et al.	436	52	
	AI	6,262,907 B1	07/17/01	Lien et al.	365	49	
	AJ	6,454,945 B1	09/24/02	Weigl et al.	210	634	
	AK	6,541,213 B1	04/01/03	Weigl et al.	435	7.1	

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/A.C./	AL	WO 02/076878 A3	10/03/02	WIPO				X
	AM	WO 02/064253 A2	08/22/02	WIPO				X
	AN	WO 01/12327 A1	02/22/01	WIPO				X
	AO	WO 99/05512	02/04/99	WIPO				X
	AP	JP2002277478	09/25/02	JAPAN			X	

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/A.C./	AQ	John Oakey, et al., Laminar-Flow-Based Separations at the Microscale, Biotechnol. Prog. 2002, 18, 1439-1442
/A.C./	AR	Paul J.A. Kenis, et al., Fabrication Inside Microchannels Using Fluid Flow, Vol. 33, No. 12, 2000, Accounts of Chemical Research.
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